



Form PTO-1449 (Rev. 7-80) 42-44F (F-49) <b>INFORMATION DISCLOSURE CITATION</b> (Use several sheets if necessary)		U.S. Department of Commerce Patent and Trademark Office		Atty. Docket No.: F-8521 Serial No.: 10/519,696 Applicant: Lothar DUNSCH, et al. Filing Date: February 28, 2005 Group: 1709			
<b>U.S. PATENT DOCUMENTS</b>							
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
<b>FOREIGN PATENT DOCUMENTS</b>							
		Document Number	Date	Country	Class	Subclass	<div style="text-align: center;">Translation</div> <div style="display: flex; justify-content: space-around; font-size: small;"> <span>Yes</span> <span>No</span> </div>
TRANSLATION KEY: * English Abstract. <sup>F</sup> Concise statement of relevance provided in foreign search report. <sup>C</sup> Concise statement of relevance provided in specification or in attachment to document. <sup>S</sup> Concise statement of relevance provided in IDS. <sup>P</sup> Relevant portion of document translated. <sup>O</sup> English abstract only - copy of document in pct search.							
<b>OTHER INFORMATION DISCLOSURE CITATIONS (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
	01	STEVENSON S. et al.; "Small-bandgap endohedral metallofullerenes in high yield and purity"; NATURE, September 2, 1999, Macmillan Magazines, UK, Vol. 401, No. 6748, Pages 55-57 XP002262357 ISSN: 0028-0836					
	02	DATABASE CA "Online! Chemical Abstracts Service, Columbus, Ohio, US; FENG, Lai et al.; "Isolation and characterization of the endohedral metallofullerene Tb3N@C8"; Database accession no. 137:209802 CA XP002262359 Zusammenfassung & Gaodeng Xuexiao Huaxue (2002), 23(6), 996-998, 2002					
	03	TAGMATARCHIS Nikos et al.; "Isolation and spectroscopic study of a series of mono and dierbium endohedral C82 and C84 metallofullerenes"; J Phys Chem B; Journal of Physical Chemistry B, November 2000, ACS, Washington, D.C., USA, Vol. 104, No. 47, Pages 11010-11012, XP002262358					
EXAMINER Jennifer A. Smith				DATE CONSIDERED			
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							